

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/674,648	CHOE ET AL.	
	Examiner Marianne L. Padgett	Art Unit 1762	Page 1 of 2

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	U	2 machine translations of JP 9-64 323, cited above
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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J	US-			
K	US-			
L	US-			
M	US-			

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